Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,356	TAKASE ET AL.
Examiner	Art Unit
EDMUND H. LEE	1791

SEARCHED					
SEAROHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
264/272.15	,272.17,275	7/10/2009	EHL	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
UPDATED	7/10/2009	EHL	